


<b>Search Notes</b>  	<b>Application/Control No.</b>  10812509	<b>Applicant(s)/Patent Under Reexamination</b>  SAPIRO ET AL.
	<b>Examiner</b>  HARESH N PATEL	<b>Art Unit</b>  2454

SEARCHED			
Class	Subclass	Date	Examiner
709	217-228	11/06/2008	H.P.
714	4	11/06/2008	H.P.
715	738	11/06/2008	H.P.
707	200	11/06/2008	H.P.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST; US-PAT, US-PUB, EPO, JPO, USOCR, DERWENT, IBM_TDB; IEEE XPLORE, ACM DIGITAL LIBRARY, GOOGLE.	11/06/2008	H.P.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	224	11/06/2008	H.P.
714	4	11/06/2008	H.P.
715	738	11/06/2008	H.P.
707	200	11/06/2008	H.P.

	/HARESH N PATEL/ Primary Examiner.Art Unit 2454
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